

**Search Notes**

Application/Control No.

10/774,827

Examiner

Michael Trinh

Applicant(s)/Patent under  
Reexamination

WEIS ET AL.

Art Unit

2822

**SEARCHED**

Class	Subclass	Date	Examiner
257	Updated previous subclasses	10/1/2006	MT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR